



Fetterman 7-17

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Patent Application

Applicant(s): H. Scott Fetterman et al.  
Case: 7-17  
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Filing Date: October 31, 2001  
Group: 2829  
Examiner: Evan T. Pert

I hereby certify that this paper is being deposited on this date with the U.S. Postal Service as first class mail addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

Signature: Laura M. Hanin Date: June 25, 2003

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Laura M. Hanin*

*7-17-03*

Title: Stress Migration Test Structure  
and Method Therefor

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Sir:

In accordance with the Manual of Patent Examining Procedure, Section 601.03, please change the mailing address for all correspondence in the above-identified application to:

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